

<b>Notice of References Cited</b>	Application/Control No. 09/996,446	Applicant(s)/Patent Under Reexamination DOWNEY ET AL.	
	Examiner Jermele M. Hollington	Art Unit 2829	Page 1 of 1

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	U	Mullet et al, Device Electronics for Integrated Circuits, 1986, John Wiley & Sons, Second Edition, pages 79-82
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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